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#### What is "[Embedded - Microcontrollers](#)"?

"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

#### Applications of "[Embedded - Microcontrollers](#)"

##### Details

Product Status	Active
Core Processor	ARM® Cortex®-M0
Core Size	32-Bit Single-Core
Speed	48MHz
Connectivity	CANbus, HDMI-CEC, I²C, IrDA, LINbus, SPI, UART/USART, USB
Peripherals	DMA, I²S, POR, PWM, WDT
Number of I/O	16
Program Memory Size	16KB (16K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	6K x 8
Voltage - Supply (Vcc/Vdd)	1.65V ~ 3.6V
Data Converters	A/D 12x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	20-TSSOP (0.173", 4.40mm Width)
Supplier Device Package	20-TSSOP
Purchase URL	<a href="https://www.e-xfl.com/product-detail/stmicroelectronics/stm32f042f4p6">https://www.e-xfl.com/product-detail/stmicroelectronics/stm32f042f4p6</a>

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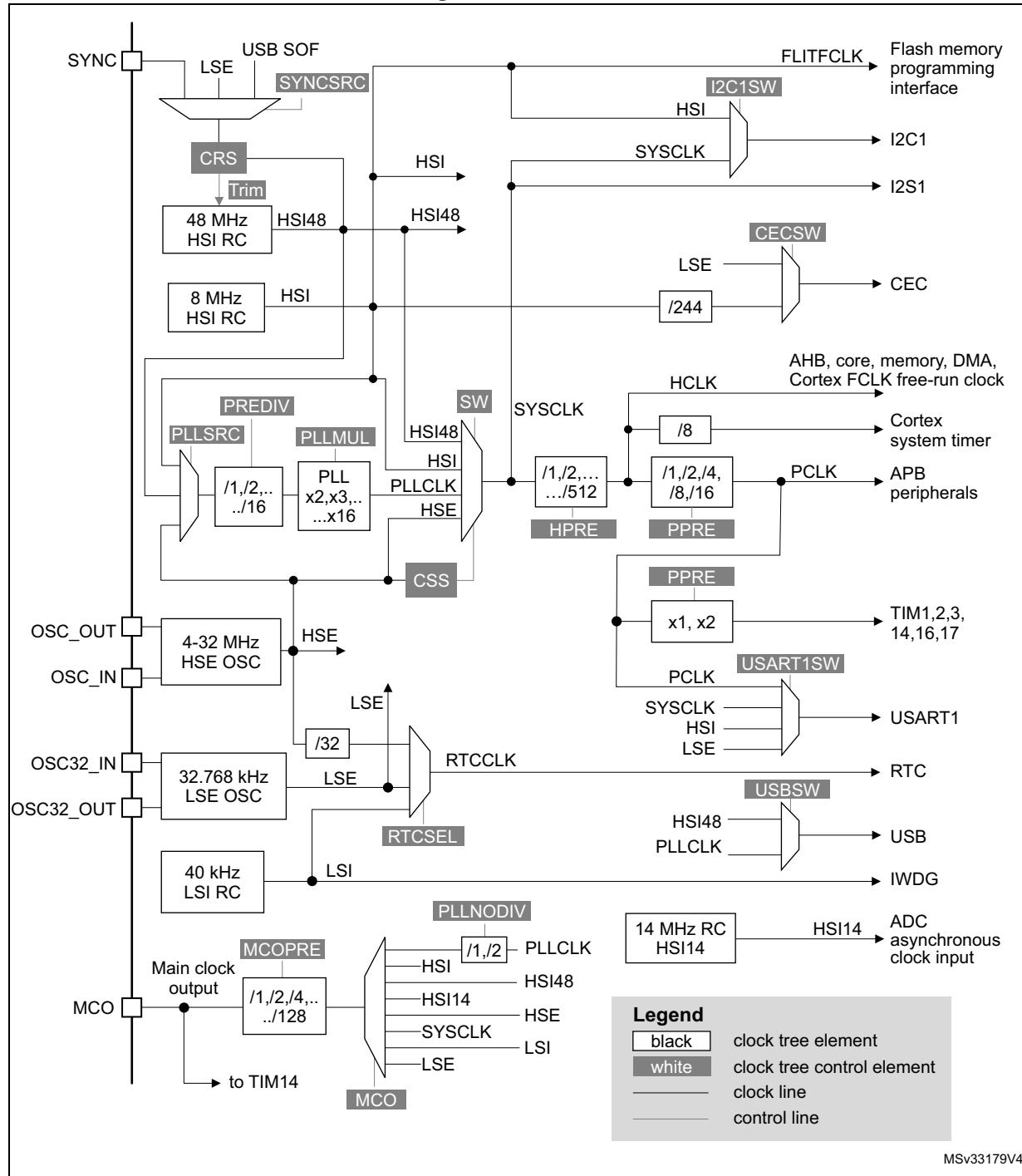
### 3.6 Clocks and startup

System clock selection is performed on startup, however the internal RC 8 MHz oscillator is selected as default CPU clock on reset. An external 4-32 MHz clock can be selected, in which case it is monitored for failure. If failure is detected, the system automatically switches back to the internal RC oscillator. A software interrupt is generated if enabled. Similarly, full interrupt management of the PLL clock entry is available when necessary (for example on failure of an indirectly used external crystal, resonator or oscillator).

Several prescalers allow the application to configure the frequency of the AHB and the APB domains. The maximum frequency of the AHB and the APB domains is 48 MHz.

Additionally, also the internal RC 48 MHz oscillator can be selected for system clock or PLL input source. This oscillator can be automatically fine-trimmed by the means of the CRS peripheral using the external synchronization.

**Figure 2. Clock tree**



## 3.7 General-purpose inputs/outputs (GPIOs)

Each of the GPIO pins can be configured by software as output (push-pull or open-drain), as input (with or without pull-up or pull-down) or as peripheral alternate function. Most of the GPIO pins are shared with digital or analog alternate functions.

from the CPU clock, allowing the I2C1 to wake up the MCU from Stop mode on address match.

The I2C peripheral can be served by the DMA controller.

**Table 9. STM32F042x4/x6 I<sup>2</sup>C implementation**

I <sup>2</sup> C features <sup>(1)</sup>	I2C1
7-bit addressing mode	X
10-bit addressing mode	X
Standard mode (up to 100 kbit/s)	X
Fast mode (up to 400 kbit/s)	X
Fast Mode Plus with 20 mA output drive I/Os (up to 1 Mbit/s)	X
Independent clock	X
SMBus	X
Wakeup from STOP	X

1. X = supported.

### 3.15 Universal synchronous/asynchronous receiver/transmitter (USART)

The device embeds two universal synchronous/asynchronous receivers/transmitters (USART1, USART2) which communicate at speeds of up to 6 Mbit/s.

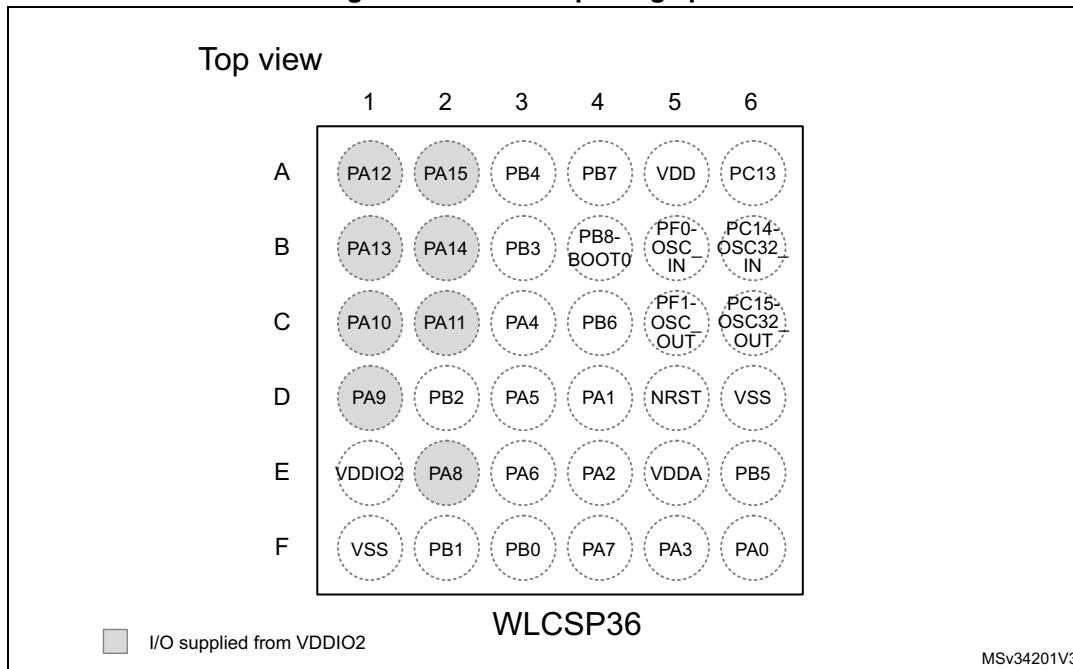
They provide hardware management of the CTS, RTS and RS485 DE signals, multiprocessor communication mode, master synchronous communication and single-wire half-duplex communication mode. USART1 supports also SmartCard communication (ISO 7816), IrDA SIR ENDEC, LIN Master/Slave capability and auto baud rate feature, and has a clock domain independent of the CPU clock, allowing to wake up the MCU from Stop mode.

The USART interfaces can be served by the DMA controller.

**Table 10. STM32F042x4/x6 USART implementation**

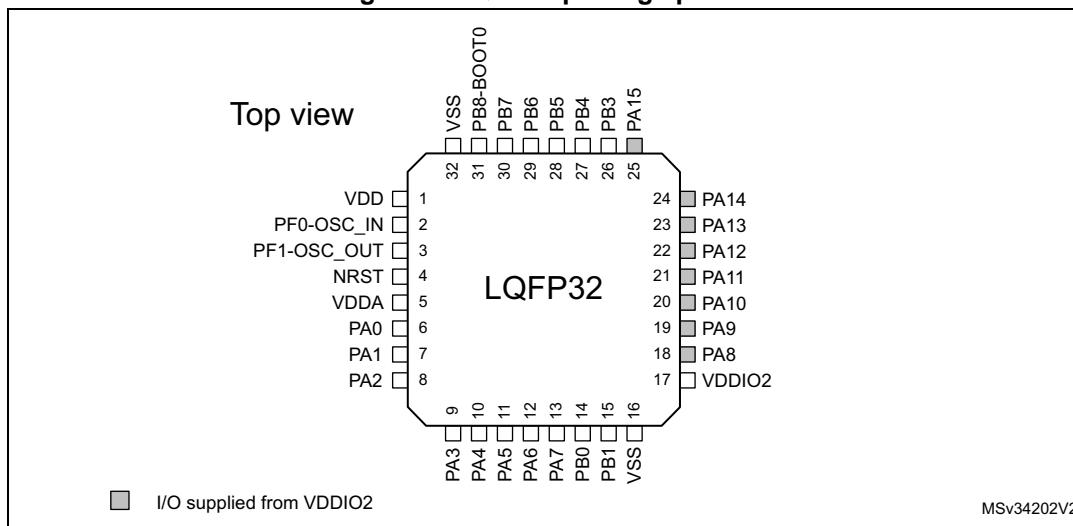
USART modes/features <sup>(1)</sup>	USART1	USART2
Hardware flow control for modem	X	X
Continuous communication using DMA	X	X
Multiprocessor communication	X	X
Synchronous mode	X	X
Smartcard mode	X	-
Single-wire half-duplex communication	X	X
IrDA SIR ENDEC block	X	-
LIN mode	X	-
Dual clock domain and wakeup from Stop mode	X	-
Receiver timeout interrupt	X	-

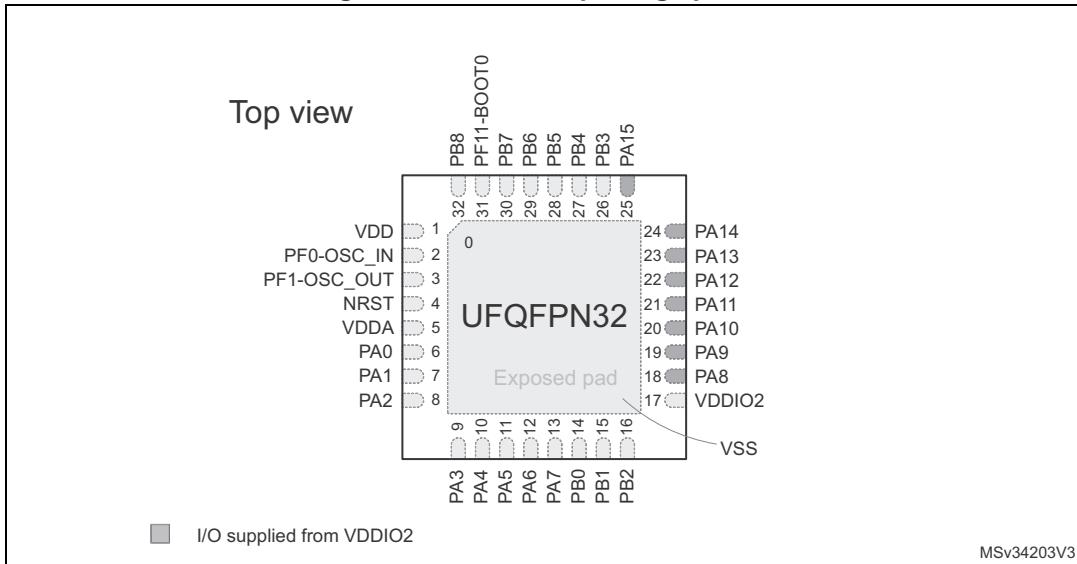
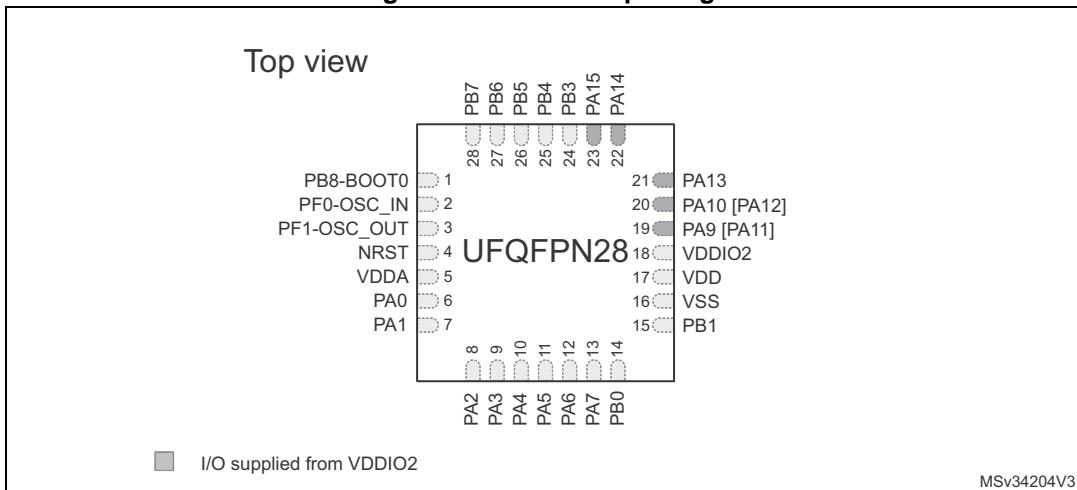
Figure 5. WL CSP36 package pinout



1. The above figure shows the package in top view, changing from bottom view in the previous document versions.

Figure 6. LQFP32 package pinout



**Figure 7. UFQFPN32 package pinout****Figure 8. UFQFPN28 package**

1. Pin pair PA11/12 can be remapped in place of pin pair PA9/10 using the SYSCFG\_CFGR1 register.

Table 14. Alternate functions selected through GPIOA\_AFR registers for port A

Pin name	AF0	AF1	AF2	AF3	AF4	AF5	AF6	AF7
PA0	-	USART2_CTS	TIM2_CH1_ETR	TSC_G1_IO1	-	-	-	-
PA1	EVENTOUT	USART2_RTS	TIM2_CH2	TSC_G1_IO2	-	-	-	-
PA2	-	USART2_TX	TIM2_CH3	TSC_G1_IO3	-	-	-	-
PA3	-	USART2_RX	TIM2_CH4	TSC_G1_IO4	-	-	-	-
PA4	SPI1_NSS, I2S1_WS	USART2_CK	USB_NOE	TSC_G2_IO1	TIM14_CH1	-	-	-
PA5	SPI1_SCK, I2S1_CK	CEC	TIM2_CH1_ETR	TSC_G2_IO2	-	-	-	-
PA6	SPI1_MISO, I2S1_MCK	TIM3_CH1	TIM1_BKIN	TSC_G2_IO3	-	TIM16_CH1	EVENTOUT	-
PA7	SPI1_MOSI, I2S1_SD	TIM3_CH2	TIM1_CH1N	TSC_G2_IO4	TIM14_CH1	TIM17_CH1	EVENTOUT	-
PA8	MCO	USART1_CK	TIM1_CH1	EVENTOUT	CRS_SYNC	-	-	-
PA9	-	USART1_TX	TIM1_CH2	TSC_G4_IO1	I2C1_SCL	MCO	-	-
PA10	TIM17_BKIN	USART1_RX	TIM1_CH3	TSC_G4_IO2	I2C1_SDA	-	-	-
PA11	EVENTOUT	USART1_CTS	TIM1_CH4	TSC_G4_IO3	CAN_RX	I2C1_SCL	-	-
PA12	EVENTOUT	USART1_RTS	TIM1_ETR	TSC_G4_IO4	CAN_TX	I2C1_SDA	-	-
PA13	SWDIO	IR_OUT	USB_NOE	-	-	-	-	-
PA14	SWCLK	USART2_TX	-	-	-	-	-	-
PA15	SPI1_NSS, I2S1_WS	USART2_RX	TIM2_CH1_ETR	EVENTOUT	-	USB_NOE	-	-

**Table 17. STM32F042x4/x6 peripheral register boundary addresses**

Bus	Boundary address	Size	Peripheral
	0x4800 1800 - 0x5FFF FFFF	~384 MB	Reserved
AHB2	0x4800 1400 - 0x4800 17FF	1 KB	GPIOF
	0x4800 0C00 - 0x4800 13FF	2 KB	Reserved
	0x4800 0800 - 0x4800 0BFF	1 KB	GPIOC
	0x4800 0400 - 0x4800 07FF	1 KB	GPIOB
	0x4800 0000 - 0x4800 03FF	1 KB	GPIOA
	0x4002 4400 - 0x47FF FFFF	~128 MB	Reserved
AHB1	0x4002 4000 - 0x4002 43FF	1 KB	TSC
	0x4002 3400 - 0x4002 3FFF	3 KB	Reserved
	0x4002 3000 - 0x4002 33FF	1 KB	CRC
	0x4002 2400 - 0x4002 2FFF	3 KB	Reserved
	0x4002 2000 - 0x4002 23FF	1 KB	Flash memory interface
	0x4002 1400 - 0x4002 1FFF	3 KB	Reserved
	0x4002 1000 - 0x4002 13FF	1 KB	RCC
	0x4002 0400 - 0x4002 0FFF	3 KB	Reserved
	0x4002 0000 - 0x4002 03FF	1 KB	DMA
	0x4001 8000 - 0x4001 FFFF	32 KB	Reserved
APB	0x4001 5C00 - 0x4001 7FFF	9 KB	Reserved
	0x4001 5800 - 0x4001 5BFF	1 KB	DBGMCU
	0x4001 4C00 - 0x4001 57FF	3 KB	Reserved
	0x4001 4800 - 0x4001 4BFF	1 KB	TIM17
	0x4001 4400 - 0x4001 47FF	1 KB	TIM16
	0x4001 3C00 - 0x4001 43FF	2 KB	Reserved
	0x4001 3800 - 0x4001 3BFF	1 KB	USART1
	0x4001 3400 - 0x4001 37FF	1 KB	Reserved
	0x4001 3000 - 0x4001 33FF	1 KB	SPI1/I2S1
	0x4001 2C00 - 0x4001 2FFF	1 KB	TIM1
	0x4001 2800 - 0x4001 2BFF	1 KB	Reserved
	0x4001 2400 - 0x4001 27FF	1 KB	ADC
	0x4001 0800 - 0x4001 23FF	7 KB	Reserved
	0x4001 0400 - 0x4001 07FF	1 KB	EXTI
	0x4001 0000 - 0x4001 03FF	1 KB	SYSCFG
	0x4000 8000 - 0x4000 FFFF	32 KB	Reserved

**Table 22. Operating conditions at power-up / power-down**

Symbol	Parameter	Conditions	Min	Max	Unit
$t_{VDD}$	$V_{DD}$ rise time rate	-	0	$\infty$	$\mu\text{s}/\text{V}$
	$V_{DD}$ fall time rate		20	$\infty$	
$t_{VDDA}$	$V_{DDA}$ rise time rate	-	0	$\infty$	$\mu\text{s}/\text{V}$
	$V_{DDA}$ fall time rate		20	$\infty$	

### 6.3.3 Embedded reset and power control block characteristics

The parameters given in [Table 23](#) are derived from tests performed under the ambient temperature and supply voltage conditions summarized in [Table 21: General operating conditions](#).

**Table 23. Embedded reset and power control block characteristics**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{POR/PDR}^{(1)}$	Power on/power down reset threshold	Falling edge <sup>(2)</sup>	1.80	1.88	1.96 <sup>(3)</sup>	V
		Rising edge	1.84 <sup>(3)</sup>	1.92	2.00	V
$V_{PDRhyst}$	PDR hysteresis	-	-	40	-	mV
$t_{RSTTEMPO}^{(4)}$	Reset temporization	-	1.50	2.50	4.50	ms

1. The PDR detector monitors  $V_{DD}$  and also  $V_{DDA}$  (if kept enabled in the option bytes). The POR detector monitors only  $V_{DD}$ .
2. The product behavior is guaranteed by design down to the minimum  $V_{POR/PDR}$  value.
3. Data based on characterization results, not tested in production.
4. Guaranteed by design, not tested in production.

**Table 24. Programmable voltage detector characteristics**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{PVD0}$	PVD threshold 0	Rising edge	2.1	2.18	2.26	V
		Falling edge	2	2.08	2.16	V
$V_{PVD1}$	PVD threshold 1	Rising edge	2.19	2.28	2.37	V
		Falling edge	2.09	2.18	2.27	V
$V_{PVD2}$	PVD threshold 2	Rising edge	2.28	2.38	2.48	V
		Falling edge	2.18	2.28	2.38	V
$V_{PVD3}$	PVD threshold 3	Rising edge	2.38	2.48	2.58	V
		Falling edge	2.28	2.38	2.48	V
$V_{PVD4}$	PVD threshold 4	Rising edge	2.47	2.58	2.69	V
		Falling edge	2.37	2.48	2.59	V
$V_{PVD5}$	PVD threshold 5	Rising edge	2.57	2.68	2.79	V
		Falling edge	2.47	2.58	2.69	V

Table 32. Peripheral current consumption (continued)

Peripheral	Typical consumption at 25 °C	Unit
APB-Bridge <sup>(2)</sup>	2.9	µA/MHz
ADC <sup>(3)</sup>	3.9	
CAN	12.9	
CEC	1.5	
CRS	1.0	
DBG (MCU Debug Support)	0.2	
I2C1	3.6	
PWR	1.4	
SPI1	8.5	
SPI2	6.1	
SYSCFG	1.8	
TIM1	15.1	
TIM2	16.8	
TIM3	11.7	
TIM14	5.5	
TIM16	7.0	
TIM17	6.9	
USART1	17.8	
USART2	5.6	
USB	4.9	
WWDG	1.4	
<b>All APB peripherals</b>	<b>136.7</b>	

1. The BusMatrix is automatically active when at least one master is ON (CPU, DMA).
2. The APB Bridge is automatically active when at least one peripheral is ON on the Bus.
3. The power consumption of the analog part ( $I_{DDA}$ ) of peripherals such as ADC is not included. Refer to the tables of characteristics in the subsequent sections.

### High-speed internal 48 MHz (HSI48) RC oscillator

**Table 40. HSI48 oscillator characteristics<sup>(1)</sup>**

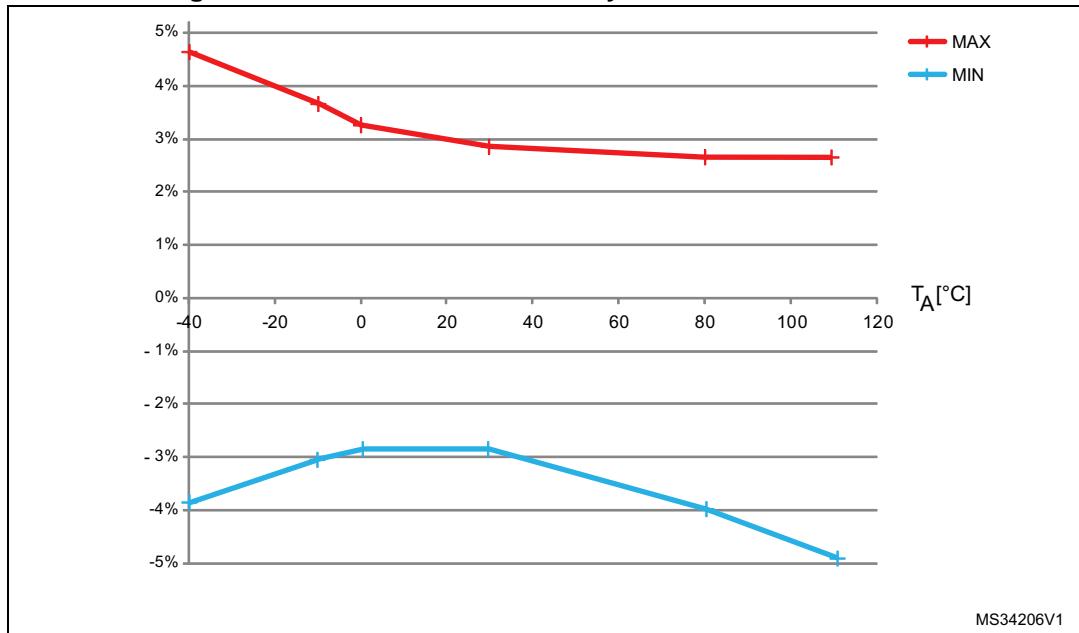
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$f_{HSI48}$	Frequency	-	-	48	-	MHz
TRIM	HSI48 user-trimming step	-	0.09 <sup>(2)</sup>	0.14	0.2 <sup>(2)</sup>	%
DuC <sub>y(HSI48)</sub>	Duty cycle	-	45 <sup>(2)</sup>	-	55 <sup>(2)</sup>	%
ACC <sub>HSI48</sub>	Accuracy of the HSI48 oscillator (factory calibrated)	$T_A = -40$ to $105$ °C	-4.9 <sup>(3)</sup>	-	4.7 <sup>(3)</sup>	%
		$T_A = -10$ to $85$ °C	-4.1 <sup>(3)</sup>	-	3.7 <sup>(3)</sup>	%
		$T_A = 0$ to $70$ °C	-3.8 <sup>(3)</sup>	-	3.4 <sup>(3)</sup>	%
		$T_A = 25$ °C	-2.8	-	2.9	%
$t_{su(HSI48)}$	HSI48 oscillator startup time	-	-	-	6 <sup>(2)</sup>	μs
$I_{DDA(HSI48)}$	HSI48 oscillator power consumption	-	-	312	350 <sup>(2)</sup>	μA

1.  $V_{DDA} = 3.3$  V,  $T_A = -40$  to  $105$  °C unless otherwise specified.

2. Guaranteed by design, not tested in production.

3. Data based on characterization results, not tested in production.

**Figure 21. HSI48 oscillator accuracy characterization results**



**Table 49. I/O current injection susceptibility**

Symbol	Description	Functional susceptibility		Unit
		Negative injection	Positive injection	
$I_{INJ}$	Injected current on PA12 pin	-0	+5	mA
	Injected current on PA9, PB3, PB13, PF11 pins with induced leakage current on adjacent pins less than 50 $\mu$ A	-5	NA	
	Injected current on PB0, PB1 and all other FT and FTf pins	-5	NA	
	Injected current on all other TC, TTa and RST pins	-5	+5	

### 6.3.14 I/O port characteristics

#### General input/output characteristics

Unless otherwise specified, the parameters given in [Table 50](#) are derived from tests performed under the conditions summarized in [Table 21: General operating conditions](#). All I/Os are designed as CMOS- and TTL-compliant.

**Table 50. I/O static characteristics**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{IL}$	Low level input voltage	TC and TTa I/O	-	-	$0.3 V_{DDIOx} + 0.07^{(1)}$	V
		FT and FTf I/O	-	-	$0.475 V_{DDIOx} - 0.2^{(1)}$	
		All I/Os	-	-	$0.3 V_{DDIOx}$	
$V_{IH}$	High level input voltage	TC and TTa I/O	$0.445 V_{DDIOx} + 0.398^{(1)}$	-	-	V
		FT and FTf I/O	$0.5 V_{DDIOx} + 0.2^{(1)}$	-	-	
		All I/Os	$0.7 V_{DDIOx}$	-	-	
$V_{hys}$	Schmitt trigger hysteresis	TC and TTa I/O	-	$200^{(1)}$	-	mV
		FT and FTf I/O	-	$100^{(1)}$	-	
$I_{lkg}$	Input leakage current <sup>(2)</sup>	TC, FT and FTf I/O TTa in digital mode $V_{SS} \leq V_{IN} \leq V_{DDIOx}$	-	-	$\pm 0.1$	$\mu$ A
		TTa in digital mode $V_{DDIOx} \leq V_{IN} \leq V_{DDA}$	-	-	1	
		TTa in analog mode $V_{SS} \leq V_{IN} \leq V_{DDA}$	-	-	$\pm 0.2$	
		FT and FTf I/O $V_{DDIOx} \leq V_{IN} \leq 5 V$	-	-	10	
$R_{PU}$	Weak pull-up equivalent resistor <sup>(3)</sup>	$V_{IN} = V_{SS}$	25	40	55	k $\Omega$

**Table 50. I/O static characteristics (continued)**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{PD}$	Weak pull-down equivalent resistor <sup>(3)</sup>	$V_{IN} = -V_{DDIOX}$	25	40	55	kΩ
$C_{IO}$	I/O pin capacitance	-	-	5	-	pF

1. Data based on design simulation only. Not tested in production.
2. The leakage could be higher than the maximum value, if negative current is injected on adjacent pins. Refer to [Table 49: I/O current injection susceptibility](#).
3. Pull-up and pull-down resistors are designed with a true resistance in series with a switchable PMOS/NMOS. This PMOS/NMOS contribution to the series resistance is minimal (~10% order).

All I/Os are CMOS- and TTL-compliant (no software configuration required). Their characteristics cover more than the strict CMOS-technology or TTL parameters. The coverage of these requirements is shown in [Figure 22](#) for standard I/Os, and in [Figure 23](#) for 5 V-tolerant I/Os. The following curves are design simulation results, not tested in production.

## Output driving current

The GPIOs (general purpose input/outputs) can sink or source up to +/- 8 mA, and sink or source up to +/- 20 mA (with a relaxed  $V_{OL}/V_{OH}$ ).

In the user application, the number of I/O pins which can drive current must be limited to respect the absolute maximum rating specified in [Section 6.2](#):

- The sum of the currents sourced by all the I/Os on  $V_{DDIOx}$ , plus the maximum consumption of the MCU sourced on  $V_{DD}$ , cannot exceed the absolute maximum rating  $\Sigma I_{VDD}$  (see [Table 18: Voltage characteristics](#)).
- The sum of the currents sunk by all the I/Os on  $V_{SS}$ , plus the maximum consumption of the MCU sunk on  $V_{SS}$ , cannot exceed the absolute maximum rating  $\Sigma I_{VSS}$  (see [Table 18: Voltage characteristics](#)).

## Output voltage levels

Unless otherwise specified, the parameters given in the table below are derived from tests performed under the ambient temperature and supply voltage conditions summarized in [Table 21: General operating conditions](#). All I/Os are CMOS- and TTL-compliant (FT, TTa or TC unless otherwise specified).

**Table 51. Output voltage characteristics<sup>(1)</sup>**

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{OL}$	Output low level voltage for an I/O pin	CMOS port <sup>(2)</sup> $ I_{IO}  = 8 \text{ mA}$ $V_{DDIOx} \geq 2.7 \text{ V}$	-	0.4	V
$V_{OH}$	Output high level voltage for an I/O pin		$V_{DDIOx}-0.4$	-	
$V_{OL}$	Output low level voltage for an I/O pin	TTL port <sup>(2)</sup> $ I_{IO}  = 8 \text{ mA}$ $V_{DDIOx} \geq 2.7 \text{ V}$	-	0.4	V
$V_{OH}$	Output high level voltage for an I/O pin		2.4	-	
$V_{OL}^{(3)}$	Output low level voltage for an I/O pin	$ I_{IO}  = 20 \text{ mA}$ $V_{DDIOx} \geq 2.7 \text{ V}$	-	1.3	V
$V_{OH}^{(3)}$	Output high level voltage for an I/O pin		$V_{DDIOx}-1.3$	-	
$V_{OL}^{(3)}$	Output low level voltage for an I/O pin	$ I_{IO}  = 6 \text{ mA}$ $V_{DDIOx} \geq 2 \text{ V}$	-	0.4	V
$V_{OH}^{(3)}$	Output high level voltage for an I/O pin		$V_{DDIOx}-0.4$	-	
$V_{OL}^{(4)}$	Output low level voltage for an I/O pin	$ I_{IO}  = 4 \text{ mA}$	-	0.4	V
$V_{OH}^{(4)}$	Output high level voltage for an I/O pin		$V_{DDIOx}-0.4$	-	V
$V_{OLFm+}^{(3)}$	Output low level voltage for an FTf I/O pin in Fm+ mode	$ I_{IO}  = 20 \text{ mA}$ $V_{DDIOx} \geq 2.7 \text{ V}$	-	0.4	V
			$ I_{IO}  = 10 \text{ mA}$	-	0.4

1. The  $I_{IO}$  current sourced or sunk by the device must always respect the absolute maximum rating specified in [Table 18: Voltage characteristics](#), and the sum of the currents sourced or sunk by all the I/Os (I/O ports and control pins) must always respect the absolute maximum ratings  $\Sigma I_{IO}$ .
2. TTL and CMOS outputs are compatible with JEDEC standards JESD36 and JESD52.
3. Data based on characterization results. Not tested in production.
4. Data based on characterization results. Not tested in production.

### Input/output AC characteristics

The definition and values of input/output AC characteristics are given in [Figure 24](#) and [Table 52](#), respectively. Unless otherwise specified, the parameters given are derived from tests performed under the ambient temperature and supply voltage conditions summarized in [Table 21: General operating conditions](#).

**Table 52. I/O AC characteristics<sup>(1)(2)</sup>**

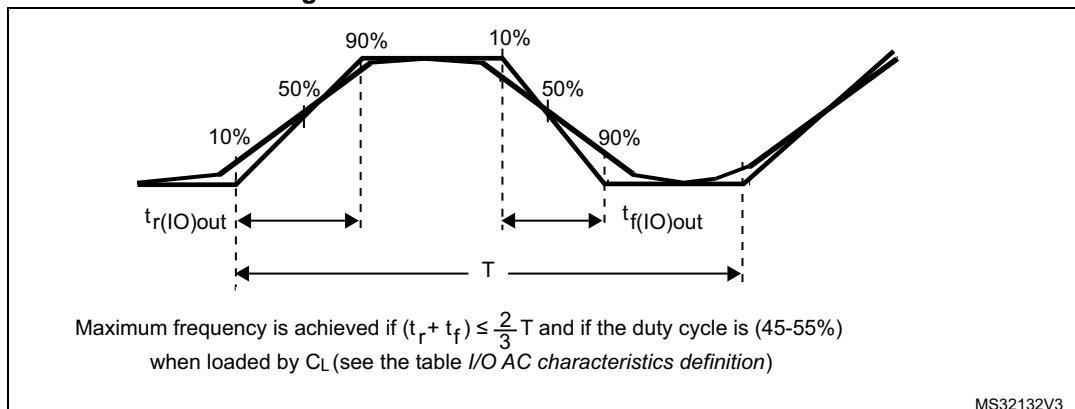
OSPEEDRy [1:0] value <sup>(1)</sup>	Symbol	Parameter	Conditions	Min	Max	Unit
x0	$f_{max(IO)out}$	Maximum frequency <sup>(3)</sup>	$C_L = 50 \text{ pF}, V_{DDIOx} \geq 2 \text{ V}$	-	2	MHz
	$t_f(IO)out$	Output fall time		-	125	ns
	$t_r(IO)out$	Output rise time		-	125	
	$f_{max(IO)out}$	Maximum frequency <sup>(3)</sup>	$C_L = 50 \text{ pF}, V_{DDIOx} < 2 \text{ V}$	-	1	MHz
	$t_f(IO)out$	Output fall time		-	125	ns
	$t_r(IO)out$	Output rise time		-	125	
01	$f_{max(IO)out}$	Maximum frequency <sup>(3)</sup>	$C_L = 50 \text{ pF}, V_{DDIOx} \geq 2 \text{ V}$	-	10	MHz
	$t_f(IO)out$	Output fall time		-	25	ns
	$t_r(IO)out$	Output rise time		-	25	
	$f_{max(IO)out}$	Maximum frequency <sup>(3)</sup>	$C_L = 50 \text{ pF}, V_{DDIOx} < 2 \text{ V}$	-	4	MHz
	$t_f(IO)out$	Output fall time		-	62.5	ns
	$t_r(IO)out$	Output rise time		-	62.5	
11	$f_{max(IO)out}$	Maximum frequency <sup>(3)</sup>	$C_L = 30 \text{ pF}, V_{DDIOx} \geq 2.7 \text{ V}$	-	50	MHz
			$C_L = 50 \text{ pF}, V_{DDIOx} \geq 2.7 \text{ V}$	-	30	
			$C_L = 50 \text{ pF}, 2 \text{ V} \leq V_{DDIOx} < 2.7 \text{ V}$	-	20	
			$C_L = 50 \text{ pF}, V_{DDIOx} < 2 \text{ V}$	-	10	
	$t_f(IO)out$	Output fall time	$C_L = 30 \text{ pF}, V_{DDIOx} \geq 2.7 \text{ V}$	-	5	ns
			$C_L = 50 \text{ pF}, V_{DDIOx} \geq 2.7 \text{ V}$	-	8	
			$C_L = 50 \text{ pF}, 2 \text{ V} \leq V_{DDIOx} < 2.7 \text{ V}$	-	12	
			$C_L = 50 \text{ pF}, V_{DDIOx} < 2 \text{ V}$	-	25	
	$t_r(IO)out$	Output rise time	$C_L = 30 \text{ pF}, V_{DDIOx} \geq 2.7 \text{ V}$	-	5	ns
			$C_L = 50 \text{ pF}, V_{DDIOx} \geq 2.7 \text{ V}$	-	8	
			$C_L = 50 \text{ pF}, 2 \text{ V} \leq V_{DDIOx} < 2.7 \text{ V}$	-	12	
			$C_L = 50 \text{ pF}, V_{DDIOx} < 2 \text{ V}$	-	25	

Table 52. I/O AC characteristics<sup>(1)(2)</sup> (continued)

OSPEEDRx[1:0] value <sup>(1)</sup>	Symbol	Parameter	Conditions	Min	Max	Unit
Fm+ configuration <sup>(4)</sup>	$f_{\max(\text{IO})\text{out}}$	Maximum frequency <sup>(3)</sup>	$C_L = 50 \text{ pF}, V_{\text{DDIO}x} \geq 2 \text{ V}$	-	2	MHz
	$t_f(\text{IO})\text{out}$	Output fall time		-	12	ns
	$t_r(\text{IO})\text{out}$	Output rise time		-	34	
	$f_{\max(\text{IO})\text{out}}$	Maximum frequency <sup>(3)</sup>	$C_L = 50 \text{ pF}, V_{\text{DDIO}x} < 2 \text{ V}$	-	0.5	MHz
	$t_f(\text{IO})\text{out}$	Output fall time		-	16	ns
	$t_r(\text{IO})\text{out}$	Output rise time		-	44	
-	$t_{\text{EXTI}pw}$	Pulse width of external signals detected by the EXTI controller	-	10	-	ns

- The I/O speed is configured using the OSPEEDRx[1:0] bits. Refer to the STM32F0xxxx RM0091 reference manual for a description of GPIO Port configuration register.
- Guaranteed by design, not tested in production.
- The maximum frequency is defined in [Figure 24](#).
- When Fm+ configuration is set, the I/O speed control is bypassed. Refer to the STM32F0xxxx reference manual RM0091 for a detailed description of Fm+ I/O configuration.

Figure 24. I/O AC characteristics definition



### 6.3.15 NRST pin characteristics

The NRST pin input driver uses the CMOS technology. It is connected to a permanent pull-up resistor,  $R_{PU}$ .

Unless otherwise specified, the parameters given in the table below are derived from tests performed under the ambient temperature and supply voltage conditions summarized in [Table 21: General operating conditions](#).

Table 53. NRST pin characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{IL(\text{NRST})}$	NRST input low level voltage	-	-	-	$0.3 V_{\text{DD}} + 0.07^{(1)}$	V
$V_{IH(\text{NRST})}$	NRST input high level voltage	-	$0.445 V_{\text{DD}} + 0.398^{(1)}$	-	-	V

Table 54. ADC characteristics (continued)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$f_{TRIG}^{(2)}$	External trigger frequency	$f_{ADC} = 14 \text{ MHz}$ , 12-bit resolution	-	-	823	kHz
		12-bit resolution	-	-	17	$1/f_{ADC}$
$V_{AIN}$	Conversion voltage range	-	0	-	$V_{DDA}$	V
$R_{AIN}^{(2)}$	External input impedance	See <a href="#">Equation 1</a> and <a href="#">Table 55</a> for details	-	-	50	kΩ
$R_{ADC}^{(2)}$	Sampling switch resistance	-	-	-	1	kΩ
$C_{ADC}^{(2)}$	Internal sample and hold capacitor	-	-	-	8	pF
$t_{CAL}^{(2)(3)}$	Calibration time	$f_{ADC} = 14 \text{ MHz}$	5.9			μs
		-	83			$1/f_{ADC}$
$W_{LATENCY}^{(2)(4)}$	ADC_DR register ready latency	ADC clock = HSI14	1.5 ADC cycles + 2 $f_{PCLK}$ cycles	-	1.5 ADC cycles + 3 $f_{PCLK}$ cycles	-
		ADC clock = PCLK/2	-	4.5	-	$f_{PCLK}$ cycle
		ADC clock = PCLK/4	-	8.5	-	$f_{PCLK}$ cycle
$t_{latr}^{(2)}$	Trigger conversion latency	$f_{ADC} = f_{PCLK}/2 = 14 \text{ MHz}$	0.196			μs
		$f_{ADC} = f_{PCLK}/2$	5.5			$1/f_{PCLK}$
		$f_{ADC} = f_{PCLK}/4 = 12 \text{ MHz}$	0.219			μs
		$f_{ADC} = f_{PCLK}/4$	10.5			$1/f_{PCLK}$
		$f_{ADC} = f_{HSI14} = 14 \text{ MHz}$	0.179	-	0.250	μs
Jitter <sub>ADC</sub>	ADC jitter on trigger conversion	$f_{ADC} = f_{HSI14}$	-	1	-	$1/f_{HSI14}$
$t_S^{(2)}$	Sampling time	$f_{ADC} = 14 \text{ MHz}$	0.107	-	17.1	μs
		-	1.5	-	239.5	$1/f_{ADC}$
$t_{STAB}^{(2)}$	Stabilization time	-	14			$1/f_{ADC}$
$t_{CONV}^{(2)}$	Total conversion time (including sampling time)	$f_{ADC} = 14 \text{ MHz}$ , 12-bit resolution	1	-	18	μs
		12-bit resolution	14 to 252 ( $t_S$ for sampling +12.5 for successive approximation)			$1/f_{ADC}$

- During conversion of the sampled value (12.5 x ADC clock period), an additional consumption of 100 μA on  $I_{DDA}$  and 60 μA on  $I_{DD}$  should be taken into account.
- Guaranteed by design, not tested in production.
- Specified value includes only ADC timing. It does not include the latency of the register access.
- This parameter specify latency for transfer of the conversion result to the ADC\_DR register. EOC flag is set at this time.

**Table 60. IWDG min/max timeout period at 40 kHz (LSI)<sup>(1)</sup>**

Prescaler divider	PR[2:0] bits	Min timeout RL[11:0]= 0x000	Max timeout RL[11:0]= 0xFFFF	Unit
/4	0	0.1	409.6	ms
/8	1	0.2	819.2	
/16	2	0.4	1638.4	
/32	3	0.8	3276.8	
/64	4	1.6	6553.6	
/128	5	3.2	13107.2	
/256	6 or 7	6.4	26214.4	

1. These timings are given for a 40 kHz clock but the microcontroller internal RC frequency can vary from 30 to 60 kHz. Moreover, given an exact RC oscillator frequency, the exact timings still depend on the phasing of the APB interface clock versus the LSI clock so that there is always a full RC period of uncertainty.

**Table 61. WWDG min/max timeout value at 48 MHz (PCLK)**

Prescaler	WDGTB	Min timeout value	Max timeout value	Unit
1	0	0.0853	5.4613	ms
2	1	0.1706	10.9226	
4	2	0.3413	21.8453	
8	3	0.6826	43.6906	

### 6.3.20 Communication interfaces

#### I<sup>2</sup>C interface characteristics

The I<sup>2</sup>C interface meets the timings requirements of the I<sup>2</sup>C-bus specification and user manual rev. 03 for:

- Standard-mode (Sm): with a bit rate up to 100 kbit/s
- Fast-mode (Fm): with a bit rate up to 400 kbit/s
- Fast-mode Plus (Fm+): with a bit rate up to 1 Mbit/s.

The I<sup>2</sup>C timings requirements are guaranteed by design when the I<sup>2</sup>Cx peripheral is properly configured (refer to Reference manual).

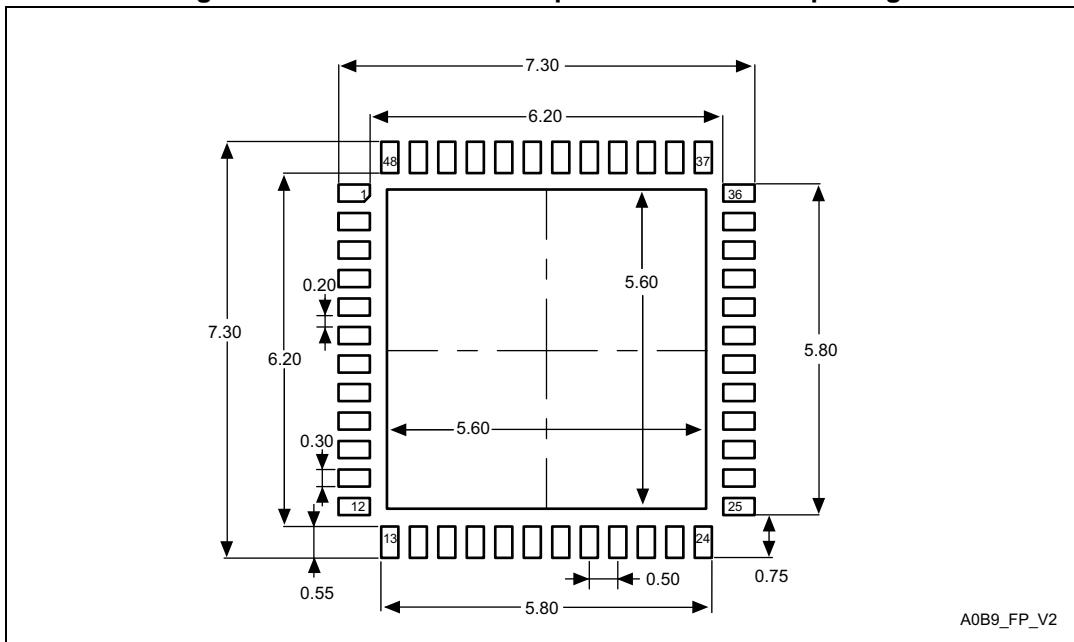
The SDA and SCL I/O requirements are met with the following restrictions: the SDA and SCL I/O pins are not “true” open-drain. When configured as open-drain, the PMOS connected between the I/O pin and V<sub>DDIOx</sub> is disabled, but is still present. Only FTf I/O pins support Fm+ low level output current maximum requirement. Refer to [Section 6.3.14: I/O port characteristics](#) for the I<sup>2</sup>C I/Os characteristics.

All I<sup>2</sup>C SDA and SCL I/Os embed an analog filter. Refer to the table below for the analog filter characteristics:

**Table 67. UFQFPN48 package mechanical data**

Symbol	millimeters			inches <sup>(1)</sup>		
	Min	Typ	Max	Min	Typ	Max
A	0.500	0.550	0.600	0.0197	0.0217	0.0236
A1	0.000	0.020	0.050	0.0000	0.0008	0.0020
D	6.900	7.000	7.100	0.2717	0.2756	0.2795
E	6.900	7.000	7.100	0.2717	0.2756	0.2795
D2	5.500	5.600	5.700	0.2165	0.2205	0.2244
E2	5.500	5.600	5.700	0.2165	0.2205	0.2244
L	0.300	0.400	0.500	0.0118	0.0157	0.0197
T	-	0.152	-	-	0.0060	-
b	0.200	0.250	0.300	0.0079	0.0098	0.0118
e	-	0.500	-	-	0.0197	-
ddd	-	-	0.080	-	-	0.0031

1. Values in inches are converted from mm and rounded to 4 decimal digits.

**Figure 37. Recommended footprint for UFQFPN48 package**

1. Dimensions are expressed in millimeters.